emldetect

February 1, 2016

Abstract

EPIC maximum likelihood multi-source point spread function fitting.

1 Instruments/Modes

Instrument	Mode
EPIC MOS:	IMAGING
EPIC PN:	IMAGING

2 Use

pipeline processing	yes	
interactive analysis	yes	

3 Description

For an input list of **eboxdetect** source locations, simultaneous maximum likelihood PSF fits to the source count distribution are performed in all energy bands of each EPIC instrument. A description of the main properties of the detection algorithm may be found in Cruddace, Hasinger, Schmitt (1988) and an overview of **emldetect** and its use in the XMM-Newton catalogue pipelines at http://xmmssc-www.star.le.ac.uk/Catalogue/2XMM/UserGuide_xmmcat.html#EmldetFit.

Fit parameters. Main free fit parameters are: the source location (image coordinates X_IMA, Y_IMA), source extent (Gaussian sigma or beta model core radius), and source count rates in each energy band for each telescope. The source location and source extent are constrained to the same best-fit value in all energy bands per EPIC instrument whereas the source count rates are adjusted to their individual best-fit value in each energy band per EPIC instrument. Derived parameters are: total source count rate, likelihood of detection (all-EPIC and in each energy band), likelihood of source extent, and up to four hardness ratios (default: four).

Output source table. A summary of all the columns in the output source list can be found in Table 2 in Section 8 on the output files. For each detected source, the table contains one row for each energy band for each instrument. The individual source rows are identified through the column entries ID_INST and ID_BAND in the output table. ID_INST refers to the EPIC instrument (1: PN, 2: MOS1, 3: MOS2, 0:



summary row). ID_BAND is the energy band number as defined by the ordering of the energy bands, i.e.: the ordering of the input images given as command-line arguments to **emldetect**. The upper and lower bounds of each energy band are available in the header keywords aa_n _ELO and aa_n _EHI where aa stands for the EPIC camera (PN, M1, or M2) and n stands for the energy band number as given in the table column ID_BAND. Additional keywords N_INST and aa_BNDS specify the number of EPIC cameras and the number of energy bands for each EPIC camera. For the definition of the basic energy bands used in the pipeline processing, see

http://xmmssc-www.star.le.ac.uk/Catalogue/3XMM-DR4/UserGuide_xmmcat.html#TabBands.

An ID_BAND value of 0 refers to the summary rows of each source, which list combined results per instrument and in total. The summary rows over the energy bands for each instrument contain sums of the entries in the individual energy bands where appropriate (counts, count rates, fluxes, and detection likelihoods). In the EPIC summary row per source with ID_INST=0, those spatial parameters are repeated that are identical for all energy bands (positions and extent values). The other columns are set to NULL.

PSF fitting. Simultaneous fitting of data from different instruments (i.e., EPIC pn and MOS data) or different exposures is supported. The PSF fitting may either be performed in single-source or in multi-source mode. In multi-source mode, neighbouring sources with overlapping PSFs are fitted simultaneously. Detection likelihoods are optimized for all the overlapping sources simultaneously, and detection likelihoods per source are calculated and written to the column DET_ML of the output source table. Selection of sources for simultaneous fitting is controlled by the distance parameter scut and by the parameter nmaxfit that gives the maximum number of sources to be fit simultaneously $(1 \leq nmaxfit)$ < 10). Sources fit simultaneously are identified in the output table through the ID_CLUSTER table column. It is also possible to fit several PSFs for each input source position by setting the parameter nmulsou to the corresponding value $(1 \le nmulsou \le 3, nmaxfit*nmulsou \le 10)$.

Two parameters determine the image region on which a source fit is performed: The parameter ecut determines the size of the subimage around each source used for fitting. The parameter scut determines the radius around each source, in which other input sources are considered for multi-PSF fitting, if the parameter nmulsou is > 1. Both ecut and scut are given as encircled energy fractions of the calibration PSF. The actual radii in pixel units therefore change slightly with energy band and source position. Alternatively, ecut and scut can be given as a fixed value in units of image pixels (if ecut or scut is > 1). The actual value for the cutout radius of each source is listed in the column CUTRAD of the output source list.

Starting with SAS 10.0 and emldetect version 5.1, a full 2d parametrization of the EPIC PSF as a function of instrument, energy, and off-axis angle is introduced (Release Notes). The PSF model can be chosen via the parameter psfmodel. Up to version 5.17.1, the medium-accuracy PSF (psfmodel=medium) is used by default. The analytical 2d PSF (psfmodel=ellbeta) is the default PSF model from version 5.17.2 on. The slew-mode PSF for EPIC/pn (psfmodel=slew) has been introduced with emldetect-6.0 and cal-3.231.

Extent fitting. If the parameter fitextent is set to "yes", the point spread function will be convolved with a source extent model, that can be set to either a Gaussian profile or a β -model profile via the parameter extentmodel. In the case of extentmodel=beta, the surface brightness is calculated as

$$f(x,y) = \left(1 + \frac{(x-x_0)^2 + (y-y_0)^2}{r_c^2}\right)^{-3/2}$$

The value of the core radius r_c is written to the column EXT of the output source list. In the case of a Gaussian extent model, σ is written to the column EXT, instead. Note that the source extent can only be determined reliably for relatively bright objects. If the likelihood of the source extent falls below the threshold given via dmlextmin (default: 10.0), point source parameters are derived.

From version 4.27 on, the extent likelihood values (EXT_ML) are corrected for the number of input images

Table 1: Default band assignments of hardness ratios HRi for the EPIC instruments and default energy intervals during pipeline processing (cf. 3XMM-DR4 catalogue description).

i	n	m	Pipeline energ	y bands [keV]
1	1	2	0.2 - 0.5	0.5 - 1.0
2	2	3	0.5 - 1.0	1.0 - 2.0
3	3	4	1.0 - 2.0	2.0 - 4.5
4	4	5	2.0 - 4.5	4.5 - 12.0

with the formalism described below in the paragraph on Detection likelihoods.

From version 4.32 on, the maximum value of the extent fit parameter can be given via the task parameter maxextent. The unit is image pixels. Large values of maxextent can lead to spurious detection of extended sources in some cases. With the parameter minextent, the minimum extent can be specified that is still considered to be significant. If the best fit extent is less than minextent, a point source model will be adopted for the source.

Detection likelihoods. All detection likelihoods are transformed to equivalent likelihoods L_2 (column DET_ML of the output source table), corresponding to the case of two free parameters to allow comparison between detection runs with different numbers of free parameters (i.e., when different numbers of input images are used):

$$L_2 = -\ln(1 - P(\frac{\nu}{2}, L'))$$
 with $L' = \sum_{i=1}^{n} L_i$

where P is the incomplete Gamma function, n is the number of energy bands involved, ν is the number of degrees of freedom of the fit ($\nu = 3 + n$ if task parameter fitextent=yes, and $\nu = 2 + n$ otherwise), and $L_i = C_i/2$ with C as defined by Cash (1979). Note that n is 1 for the individual energy-band detection likelihoods that are listed in source table rows with $ID_BAND > 0$, and n is equal to the total number of energy bands in the ID_BAND=0 summary rows. The equivalent detection likelihoods obey the simple relationship $L_2 = -\ln(p)$, where p is the probability for a random Poissonian fluctuation to have caused the observed source counts. This is in agreement with the equivalent detection likelihoods as defined in task eboxdetect (column SIGMA of eboxdetect source lists). Note that for very small numbers of source counts (less than ≈ 9 counts, Cash 1979), this relation has to be treated with caution. Therefore, it will only give a rough estimate of the number of expected spurious sources.

Hardness ratios. If detection over several energy bands is performed, up to four hardness ratios HRi are calculated from the source count rates in the individual bands (default: four). The hardness ratios are defined as follows:

$$\mathrm{HR}i = \frac{B_m - B_n}{B_m + B_n}$$

where B denotes the count rates in energy bands n and m, respectively. The energy bands n and m used to calculate the hardness ratios can be specified for each instrument via the parameters hrpndef, hrmldef, and hrmldef. The default band assignments (identical for all instruments) are given in Table 1. The band numbers n and m are assigned to the individual bands by numbering the corresponding input images in the order in which they are given on the command line. It is therefore important that the ordering of the input images is consistent with the contents of hrdef to obtain meaningful hardness ratios.

Fluxes and energy conversion factors. EPIC count rates and errors are converted to fluxes and flux errors by means of energy conversion factors (ECF = count rate / flux), given in units of 10^{11} cts cm cm / erg



via the parameter ecf per image, i.e. per camera and per energy band. Fluxes and flux errors per instrument in the output source list are the sum of the values for each energy band. All-EPIC fluxes are error-weighted means. The parameter ecf defaults to 1.0, which means that the default output fluxes of emldetect are not true source fluxes. Users need to supply appropriate energy conversion factors for their input images, depending on the instrumental setup – camera, filter, response –, the event selection expression – in particular: patterns and energy band –, and the assumed spectral shape of the sources. New ECFs were derived for the 3XMM catalogue, are listed at

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http://xmmssc-www.star.le.ac.uk/Catalogue/3XMM-DR4/UserGuide_xmmcat.html#TabNewECFs, and can be adopted for input images obtained with the same setup as described in the 3XMM documentation. In general, ECFs are estimated from spectral analyses of large source samples (or single sources), fitting or assuming a spectral shape and calculating count rates and fluxes for a given response e.g. within xspec. For the method, see Mateos et al. (2009), Section 3.5 of Rosen et al. (2016), and the technical note

http://xmmssc-www.star.le.ac.uk/Catalogue/2XMM/CAL-TN-0023-v2.0.ps,

and for examples the section "EPIC flux to count rate conversion" of the XMM-Newton Users Handbook at

http://xmm.esac.esa.int/external/xmm_user_support/documentation/uhb/epicfluxtocr.html.

OOT correction. All EPIC PN source count rates and fluxes written to the **emldetect** source list are corrected for photons that arrive during readout of the PN CCDs and therefore are not detected on the nominal source position (out-of-time events).

emldetect v4.5 to 4.27: Correction factors of 1.0626 for PrimeFullWindow mode and of 1.0223 for the PrimeFullWindowExtended mode are applied by **emldetect**. Data taken in other observing modes are left uncorrected.

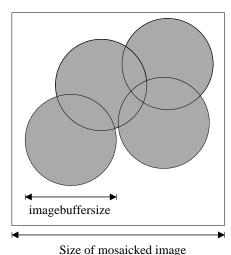
emldetect v4.28 onwards: From **eexpmap** v3.31 on, the OOT events correction is applied to the exposure maps in all observing modes. **emldetect** reads the keyword OOTCORR from the FITS header of the exposure maps. If OOTCORR is existing and set to "true", no further correction is applied by **emldetect**.

CPU saving. Since both multi-PSF fitting and extent fitting are CPU intensive, two methods exist to reduce the CPU requirements of an **emldetect** run using multi-PSF fitting. With the option withthreshold, the user can limit the application of multi-PSF fitting (as specified by nmulsou) to sources exceeding a certain threshold. The threshold is set by the parameter threshold. The corresponding input column is defined via the parameter thresholumn, which can be LIKE, SCTS, or RATE.

The second method to save CPU time for combined extent and multi-PSF fitting is provided by the option withtwostage, which is used in combination with fitextent="true" and nmulsou > 1. If withtwostage is set to "true", emldetect will perform the fit for each source in two stages: In the first stage, one extended source is fitted to the source. Only if the extent is significant, the second stage will be performed, and a multi-PSF fit with one extended source and nmulsou—1 point sources is applied. The withtwostage option avoids misidentification of close pairs of point sources as extended sources in most cases and significantly reduces CPU time.

Position errors. The final stage of the source detection process is done via ML-fitting of the PSF-shape at the given detector position to the observed photon distribution utilizing the C-statistics. The best fitting X-ray position is determined at the minimum value of C, and the 1σ errors in right ascension and declination are derived at $C = C_{\min} + 1$. The two-dimensional positional error RADEC_ERR, written to the output source list, is calculated as square root of the quadratic sum of the errors in R.A. and Dec. It translates into a one-dimensional $\sigma = \text{RADEC_ERR}/\sqrt{2}$, if symmetric errors in R.A. and Dec are assumed. Individual position errors in image coordinates can be accessed via the X_IMA_ERR and Y_IMA_ERR columns in the output source list.

XID band. The XID energy band (0.5-4.5 keV) of the X-ray Follow-up & Identification Programme is marked by ID_BAND=9 and will be present if the input parameter withxidband has been set to true. The keyword XID_BND indicates whether XID band information is present in the source table. Note that



Size of mosurence image

Figure 1: Use of parameter imagebuffersize.

the energy bands which constitute the XID band have to be specified for each instrument separately using the parameters xidpndef, xidm1def, xidm2def. Default values are the input bands 2, 3, and 4, as defined in ID_BAND column.

From v4.42.5 on, an alternative method to treat the XID band has been introduced: With the parameter xidfixed set, emldetect can be run on one XID band image per instrument using an emldetect output list as input source list. Positions and source extent values will be kept fixed, and only fluxes and detection likelihoods are determined. In this case, the input images (science images, exposure maps, background images) for the desired band (e.g. 0.5-4.5 keV) have to be prepared beforehand. The parameters xidpndef, xidm1def, xidm2def determine which energy bands from the input source list are used to provide the $start\ values$ for the fit. Note that when using this method, the parameter withxidband should be set to "no", and the parameter ecf is used to set the energy conversion factors (see paragraph on ECFs).

Mosaic images. From version 5.0 onward, the parameter imagebuffersize is implemented. The main purpose of this parameter is to make the processing of mosaic-pointings more efficient, where the mosaicked sky image will contain large areas without photon data. The value of imagebuffersize characterizes the memory that is allocated for each individual image and is given in image pixels: imagebuffersize is (at least) the size of the sub-image per pointing that contains non-zero pixels (Fig. 1). Its default is 640, which is the side length of a typical pipeline-produced EPIC image with a bin size of 4 arcsec.

4 References

Cash, W., Parameter estimation in astronomy through application of the likelihood ratio, ApJ, 228, p. 939 (1979)

Cruddace, R. G., Hasinger, G., Schmitt, J. H., The application of a maximum likelihood analysis to detection of sources in the ROSAT database, in 'Astronomy from large Databases', eds. Murtagh, F. and Heck, A., p. 177 (1988)

Mateos, S., Saxton, R. D., Read, A. M., Sembay, S., Statistical evaluation of the flux cross-calibration of the XMM-Newton EPIC cameras, A&A 496, 879 (2009)

Rosen, S. R., Webb, N. A., Watson, M. G., et al., The XMM-Newton serendipitous survey. VII. The

third XMM-Newton serendipitous source catalogue, A&A (2016), e-print arXiv:1504.07051

5 Parameters

Parameter	Mand	Type	Default	Constraints
		, , ,		
imagesets	yes	filename	image.fits	
		list		
Names of input EPIC fits mented)	$images^{1,2}$ or ϵ	event lists ³ (i	f useevents = true; ϵ	event-list mode not yet imp
,				
boxlistset	yes	filename	eboxlist.fits	
Name of input eboxdetec	ct source list			
mllistset	yes	filename	emllist.fits	
Name of output emldeted	ct source list	'		<u>'</u>
withexpimage	no	boolean	true	
Use exposure maps	<u>, </u>			
expimagesets	no	filename	expimage.fits	
		list		
Names of exposure maps ¹ ,	2			
withdetmask	no	boolean	false	
If true, only sky pixels inst	ide the detect	ion mask wil	be used in the PSF f	its.
detmasksets	no	filename	detmask.fits	
		list		
Names of detection masks	3			
bkgimagesets	yes	filename	bkgimage.fits	
		list		
Names of background image	$ges^{1,2}$			
withsourcemap	no	boolean	false	
Controls whether source m	naps (one per	input image)	will be written	
sourceimagesets	no	filename	srcmap.fits	
		list		
Names of source maps ³ (or	ne per input i	mage)		
mergedlistset	no	filename	mergedlist.fits	
Name of merged source lis	t – obsolete			
mlmin	no	float	10.0	[1.0 <param<50.0]< td=""></param<50.0]<>
Minimum detection likelih	ood for include			1
dmleytmin	no	float	10.0	[1.0 <naram<100.0]< td=""></naram<100.0]<>

Required likelihood improvement for source extent



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scut float 0.9 [0.4 < param < 100.0]no Source selection radius for multi-source fitting (expressed as fraction of the normalized PSF integrated to the desired radius). Values larger than 1.0 are interpreted as a fixed radius given in units of image pixels. ecut [0.4 < param < 100.0]float 0.68 no Source cut-out radius for PSF-fitting (expressed as fraction of the normalized PSF integrated to the desired cut-out radius).⁴ Values larger than 1.0 are interpreted as a fixed event cut-out radius given in units of image pixels. float ecf [0.001 < param < 1000]Energy conversion factors, given in units of 10¹¹ counts cm² / erg ^{1,2} float 1.0 xidecf no [0.001 < param < 1000]XID-band energy conversion factors, given in units of 10¹¹ counts cm² / erg ³ boolean no false Photon mode flag (mode not yet implemented) fitposition boolean no true Fit source positions fitextent boolean false no Fit source extent fitcounts boolean true Fit source counts (not yet implemented) fitnegative boolean false no Allow fitted count rates to become negative determineerrors no boolean true Determine statistical errors withoffsets no boolean false Flag for reading offsets from eident source list – obsolete withxidband no false Controls whether XID band output will be written usecalpsf no boolean true Read PSF from the calibration database. This parameter is obsolete and has no effect anymore. extentmodel gaussian | beta string gaussian no Model function for source extent psfmodel string ellbeta ellbeta | medium | slew no Model PSF: fully 2d parameterized analytical EPIC PSFs (ellbeta, default from version 5.17.2 on) or medium accuracy PSF for observations in pointing mode; slew for pn observations in slew mode minextent float [0.0 < param < 300]. no 1.5 Minimum allowed value for the extent parameter of an extent model in image pixels no float 20.0 [0.1 < param < 300.]

Maximum allowed value for the extent parameter of an extent model in image pixels



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withhotpixelfilter boolean false no If true, the likelihood contribution of the brightest pixel will be ignored (i.e., detections relying on a single pixel will be disregarded). nmaxfit 1,10integer 1 no Maximum number of neighbouring sources to be fit simultaneously (nmaxfit*nmulsou < 10) nmulsou no integer 1 1,3 Allow fit to split up one input source in maximum nmulsou sources (nmaxfit*nmulsou ≤ 10) 2000 integer [0 < param < 30000]no Lower energy boundaries of exposure images; units: eV; one value per input image pimax integer 4500 [0 < param < 30000]no Higher energy boundaries of exposure images; units: eV; one value per input image hrpndef 1 2 2 3 3 4 4 5 0.10 integer no Array of up to eight indices (integer) specifying the upper and lower energy band for each of the hardness ratios for PN; i.e. two numbers per energy band. hrm1def 1 2 2 3 3 4 4 5 0,10 integer no Array of up to eight indices (integer) specifying the upper and lower energy band for each of the hardness ratios for MOS1; i.e. two numbers per energy band. hrm2def 1 2 2 3 3 4 4 5 no integer 0.10Array of up to eight indices (integer) specifying the upper and lower energy band for each of the hardness ratios for MOS2; i.e. two numbers per energy band. xidpndef no integer 0.10 Index of the energy band(s) from which the images / start values for the XID band are taken for PN 2 3 4 0.10 xidm1def no integer Index of the energy band(s) from which the images / start values for the XID band are taken for MOS1 xidm2def integer 2 3 4 0.10 no Index of the energy band(s) from which the images / start values for the XID band are taken for MOS 2 xidfixed boolean false no Run emldetect on XID-band image with positions and source extent fixed to input values withthreshold boolean false no Allow splitting up into multi-PSF fitting only for sources above threshold threshold float 20 [param>0.0]Value of threshold for multi-PSF fitting threshcolumn LIKE LIKE | SCTS | RATE string no Column in input list on which threshold will be applied withtwostage no boolean false Use two-stage process for multi PSF (nmulsou > 1) fitting imagebuffersize integer 100<param<10000 no

Parameter that controls memory requirements for mosaic images.

withimagebuffersize	no	boolean	no	

Allow user-defined values of imagebuffersize.

6 Errors

This section documents warnings and errors generated by this task (if any). Note that warnings and errors can also be generated in the SAS infrastructure libraries, in which case they would not be documented here. Refer to the index of all errors and warnings available in the HTML version of the SAS documentation.

```
MissingParameter (error)
```

Missing input file name

WrongInst (error)

Unknown instrument

FileMismatch (error)

Inconsistent number of input images

FileMismatch (error)

Inconsistent instruments or bands

FileMismatch (error)

detector masks /= # instruments

FileMismatch (error)

Wrong detector mask

WrongType (error)

Input image has wrong type

WrongRefPixel (error)

Reference pixel is outside FOV

WrongParam (error)

ERROR in cut_radius

WrongPSFModel (error)

psfmodel=slew is only valid for EPIC/pn.

noPSF (error)

point response not valid

notEnoughMemory (error)

Not enough memory available to allocate arrays

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¹ Space-separated list, sorted by instrument and energy band. I.e., energy band one to energy band n of instrument one is followed by energy band one to n of instrument two.

² One per instrument per energy band; space-separated list.

³ One per instrument; space-separated list.

⁴ A parameter value of 1.0 would thus correspond to an infinite radius.

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EmptySourceList (warning)

Input source list is empty

corrective action: Exit without output results

FileMismatch (warning)

Number of PI boundaries not equal number of images corrective action: Use default values for missing boundaries

FileMismatch (warning)

Number of ECFs not equal number of images

corrective action: Use default values

MissingAttribute (warning)

Keyword is missing

corrective action: Keyword is not copied to output

WrongPointDir (warning)

Pointing direction is outside of image corrective action:

BufferOverflow (warning)

More than 50000 sources detected

corrective action: Remaining sources will be ignored

7 Input Files

- 1. PPS product (from task **evselect**): FITS images (one per instrument per energy band if program is run in imaging mode default)
- 2. PPS product (from task **evselect**): EPIC IMAGING-mode event lists (one per instrument if program is run in Photon mode not yet implemented)
- 3. PPS product (from task **eboxdetect** run in map-detect mode): EPIC **eboxdetect** source list
- 4. PPS product (from task eexpmap, optional): EPIC exposure images (one per instrument)
- 5. PPS product (from task **esplinemap**, optional): Spline background images (one per instrument per energy band)
- 6. PPS product (from task emask, optional): Detection masks (one per instrument)



8 Output Files

1. PPS product (to be read by task **srcmatch**): EPIC **emldetect** source list

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2. Optionally: source maps (one output image per input image)

Table 2: Columns of the output source table

ML_ID_SRC emldetect source number BOX_ID_SRC corresponding eboxdetect input source number instrument ID; 1: PN, 2: MOS1, 3: MOS2; 0: summary row ID_INST ID_BAND energy band number (band number 0: summary band) ID_CLUSTER cluster id; sources fit simultaneously have same number SCTS source counts SCTS_ERR source counts error AMI_X source image pixel X coordinate X_IMA_ERR

X_IMA_ERR error of image pixel X coordinate
Y_IMA source image pixel Y coordinate
Y_IMA_ERR error of image pixel Y coordinate

EXT source extent, gaussian sigma or beta model core radius (image pixel)

EXT_ERR extent error

DET_ML likelihood of detection EXT_ML likelihood of extent

BG_MAP background at source location (counts/pixel)

EXP_MAP exposure, PSF-weighted mean of the subimages around the source

(seconds, vignetting corrected)

FLUX source flux (cgs units)
FLUX_ERR source flux error

RATE source count rate (counts/sec)

RATE_ERR count rate error

RA source right ascension (degrees)
DEC source declination (degrees)

RADEC_ERR combined R.A.-Dec. error (arcsec)
LII source galactic longitude (degrees)
BII source galactic latitude (degrees)

RAWX raw X source coordinate
RAWY raw Y source coordinate
OFFAX off-axis angle (arcminutes)

CCDNR chip number

 $\begin{array}{ll} \text{HR}i \ (1 \leq i \leq 4) & \text{hardness ratios } 1..4 \\ \text{HR}i \text{_ERR} \ (1 \leq i \leq 4) & \text{hardness ratio error} \\ \text{CUTRAD} & \text{source cut out radius} \end{array}$

MASKFRAC PSF weighted on-chip fraction encircled energy fraction

VIGNETTING vignetting

ONTIME Integration time of the CCD, not vignetting corrected. Set to NULL, if CCD

no. is not defined (i.e. source center on bad pixels, gaps, damaged/noisy CCDs)

DIST_NN distance to nearest neighbour (arcsec)

FLAG quality flag placeholder (to be set by **dpssflag**)

See also

 $http://xmmssc-www.star.le.ac.uk/Catalogue/3XMM-DR4/col_coord.html \\ http://xmmssc-www.star.le.ac.uk/Catalogue/3XMM-DR4/col_srcpar.html$

9 Algorithm

subroutine emldetect

Read in EBOXDETECT source list (map detect) and sort by source count rate

Loop over sorted source list (begin with brightest source):

Selection of sources for simultaneous multi-source fitting:

- Search close neighbours within source cut radius of current source. Don't consider sources which have been processed already; mark selected sources as processed.
- 2) Repeat (1) for each close neighbour until the maximum number of sources for simultaneous fitting (max. 8; specified in parameter file) is reached. I.e., the selection of additional sources for the multi-source fitting terminates when either the maximum number of sources (parameter max_fit) is reached or when no additional sources fulfil the distance criterium (parameter scut).

Determine data area (2d-mask array) to be used for multi-source fitting: Loop over mask array: Set to 1 if pixel is (a) within event cut radius of selected source and (b) within the area marked in the detection mask; set to 0 otherwise.

Read in data:

Fill (x, y, count) data records:

Binned mode:

x,y: image pixel coordinates count: number of events in pixel

Single photon mode:

x,y: event coordinates
count:=1

Feed data records, background maps, and exposure maps into Maximum Likelihood PSF fitting algorithm:

Use Marquarth-algorithm to minimize likelihood function of multi-source PSF fit.

Remove sources from fit which do not significantly improve goodness of fit (required improvement in likelihood specified by parameter mlmin).

Set source extent to 0 if extent does not significantly improve goodness of fit (required improvement in likelihood specified by parameter dmlextmin).

Add best-fit source models (PSF + source extent) to background maps. I.e., sources which have already been fitted by the program are treated as background for the remaining sources. Note that the sources are processed in the order of decreasing count rate such that all the bright sources will have been modeled into the background map once the weak sources are processed.



```
If likelihood of detection exceeds threshold THEN
Write source parameters to EMLDETECT source list.
Add fluxes and hardness ratios.
END IF
END Loop
end subroutine emldetect
```

10 Comments

Due to coding error the likelihood values DET_ML and EXT_ML computed by **emldetect** versions 4.24 and older were overestimated by a factor 2 or more. From version 4.27 on, the correct values are computed. Note that this change strongly reduces the number of spurious detections at a certain likelihood threshold.

With introducing the analytical 2d PSF, parts of the algorithm for fitting the source positions have been changed, increasing the accuracy of image-pixel and sky-coordinate positions. Therefore, source positions determined by emldetect runs with psfmodel=ellbeta and positions determined with psfmodel=medium can differ from version 5.15.4 on.

11 Future developments

Photon mode still needs to be implemented.

References